## Summary of the San Francisco Forum

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#### Aims

# To create a QA rating system to differentiate the relative durability of module designs

- 1) Compare module designs
- 2) Provide a basis for manufacturers' warranties
- 3) Provide investors with confidence in their investments
- 4) Provide data for setting insurance rates

# To create a guideline for factory inspections of the QA system used during manufacturing.

Hosted by NREL AIST PVTEC Supported by JRC US DOE SEMI PV Group International PV Module QA Forum was held on July 15-16, 2011, at the Moscone Center in San Francisco, CA, USA.

#### Agenda

Session I. Defining the Need

Session II. Existing Standards

Session III. Regional and Application-Specific Requirements

Session IV. Proposed New Tests

Session V. Proposals for Manufacturing QA Guideline and QA Rating Methodology

Including breakout discussions

Session VI. Prioritization of Failure/Degradation Mechanisms Including breakout discussions

The detailed agenda and presentations made over the two days are available on the forum websites in English and Japanese; http://www.nrel.gov/ce/ipvmqa\_forum/ http://unit.aist.go.jp/rcpvt/ci/update/2011/qaforum\_index.html

## Manufacturing process QA

- A manufacturing QA guideline for defining factory controls and guiding inspections will be developed to become a part of the certification process.
- **D** A PV QA Task Group is being formed to:
  - Work with IEC to define factory inspections and retest guidelines that would become part of the IEC 61215 certification process
  - Work with SEMI and other standards organizations to develop standards for material, component and equipment qualification and in-line testing

#### **QA Rating Methodology**

The breakout discussions of Session V identified a list of important stresses and added any missing stresses to those already in the table.

Stress	Rating system		Environmental definition	
Voltage	Numeric value for maximum system voltage		System voltage	
Temperature	Class Hottest, Hot, Warm, Cool		Use Arrhenius behavior and create maps for rack and roof mounting	
Thermal cycling	Class A, B		Thermal cycling comes from changes in irradiance and weather	
Humidity	Class Humid, Dry		Average humidity; make map	
Snow	Numeric rating for kg of static load		Snow load from local building code	
Salt spray	Numeric severity rating		Distance from ocean	
Hail	Numeric ratir ball	To be developed at the		Ills experienced locally
UV	Class A, B	Breakout discussion		ites high-altitude or high- site
Wind	Numeric rating for maximum wind gust		Maximum wind speed seen during gusts	
Transportation	Rough/Smooth		Paved/unpaved roads, train, etc.	
Farmland	Pass/Fail		Ammonia in agricultural area	

#### Session VI. Prioritization of Failure/Degradation Mechanisms

The breakout discussions of Session VI concentrated on a priority list of known failure and degradation mechanisms.

It will not be possible to test for every failure mechanism; as such the breakout discussions of session VI prioritized the failure and degradation mechanisms that are most important in determining a module's service life. The PV QA Task Force was formed at the conclusion of the Forum and consists of five Task Groups;

- Task Group 1: PV QA Guideline for Manufacturing Consistency<br/>(leader Ivan Sinicco)
- Task Group 2: PV QA Testing for Thermal and mechanical fatigue including<br/>vibration (leader Chris Flueckiger)
- Task Group 3: PV QA Testing for Humidity, temperature, and voltage<br/>(leaders John Wohlgemuth and Neelkanth Dhere)
- Task Group 4:PV QA Testing for Diodes, shading and reverse bias<br/>(leaders Vivek Gade and Paul Robusto)
- Task Group 5:PV QA Testing for UV, temperature and humidity<br/>(leader Michael Köhl)

### Want to Volunteer!

To volunteer for **Task Group 1**, individuals may contact the leader directly or request access to the website at

http://pvqataskforcemanufacturingqa.pbworks.com/

To volunteer for **Task Groups 2-5**, individuals may contact the leaders directly or request access to the website at

http://pvqataskforceqarating.pbworks.com/

### **Roadmap-Goals and Milestones**

- □ Goals: to create a single set of QA standards and guidelines.
  - A QA rating system
  - A manufacturing QA guideline
- □ Milestones (interim):
  - QA standards and guidelines for Si PV Modules
    - Task Group proposal (s) to IEC TC82 WG2
    - ➤ Task Group proposal (s) to IEC TC82 WG2
    - Testing under the international QA standard begins

#### □ Meetings:

- #1 International QA Forum @ San Francisco, USA
- Introductory EU meeting @ Hamburg, Germany
- APEC meeting @ San Francisco, USA
- APEC meeting @ Taipei, Taiwan
- #2 International QA Forum @ Tokyo, Japan
- #3 International QA Forum @ Europe

Spring 2012.

Spring 2012

Fall, 2012

Jul.15-16, 2011 Sep.8, 2011 Sep. 15-16, 2011 Oct. 12-13, 2011 Dec. 7, 2011 Spring, 2012

### **Executive Summary**

- PV Module QA is one of the most critical challenges for healthy growth of the industry; Improved PV QA reduces risks for PV system users and investors.
- A single international approach is needed to find effective solutions. International PV Module QA Forum, managed jointly by NREL, AIST, and EU DG-JRC, to define the need and create an action plan.
- International development of a QA rating system and a guideline for a QA system for the manufacture of crystalline Si PV modules are of highest priority.
- The PV QA Task Force (currently with 5 Task Groups) is being formed to tackle these tasks and will work with IEC, SEMI and other standards organizations
- Further work will be required to extend this approach to thin-film and CPV testing and to quantify the meaning of the test results.